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# Thermal/Epithermal eXperiments with Hafnium (TEX-Hf)

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# Thermal/Epithermal eXperiments (TEX) Overview

#### TEX Goals

- New critical benchmark experiments
- Emphasis on intermediate energy range
- Create test bed: can be easily modified for different diluents





#### **TEX-Hf Overview**

- **TEX-Hf Final Design** (in review) *IER-297 CED-2* 
  - Hf is a strong neutron absorber
  - Used in naval propulsion reactors
  - No benchmarks sensitive to intermediate Hf cross sections



#### <sup>177</sup>Hf Total Neutron Cross Section

3



#### Jemima Plates

- Existing US asset at NCERC
- 93.13 93.5 wt% <sup>235</sup>U enrichment
- 3 mm thickness
- 15 inch outer diameter with central holes of various sizes
- 27 disks used in TEX-Hf
- Wedge plates used to adjust reactivity





# **TEX-Hf Final Experiment Design**

- Planet vertical lift machine
- 21 Critical Configurations
- 4 stacking methods
  - Baseline
  - Standard
  - Sandwich
  - Bunched HF





## **Baseline Configuration- No Hafnium**



- Polyethylene reflector: 1"
- Jemima plates: 3 mm
- Polyethylene moderator plates: 0"-1.5"

PE Thickness = Neutron Energy



# **Standard Stacking Configuration**





## **Sandwich Stacking Configuration**

• Maximizes sensitivity in intermediate energy range





## **Bunched Hafnium Configuration**

- Maximizes sensitivity to Hf scattering cross sections
- 12 Hf plates on top and bottom





#### **Energy Spectrum**





#### **Energy Spectrum**





# Sensitivity

Sensitivity of k<sub>eff</sub> to changes in cross section:

$$S_{k_{eff},\,\sigma} = \frac{\Delta k_{eff}/k_{eff}}{\Delta \sigma/\sigma}$$

• So a sensitivity of 0.1 would mean that increasing  $\sigma$  by X% would increase k<sub>eff</sub> by 0.1\*X%

- All simulations run with MCNP6 using ENDF/B-VII.1
- Sensitivity calculated using KSEN card
- For Hf, isotope sensitivities summed



Standard







14

#### Sensitivity- Hafnium Elastic Scatter





## Sensitivity- Hafnium Inelastic Scatter







-0.24



## Sensitivity- U-235 Fission





#### **Future Work**

**Experiment execution planned for 2018** 

#### First:

- Purchase Hf plates
- Fabricate PE parts
- Characterize all parts

#### Then:

Submission to ICSBEP



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# **Bonus- Hf Elastic Scattering**





# **Uncertainty and Bias**

#### Uncertainty

- Jemima plate mass
  - Uncertainty from previous ICSBEP benchmarks

#### PE mass

- Mass will be precisely measured after fabrication, reducing uncertainty
- Plate gaps
  - Height of stack will be measured before experiment to precisely determine gaps between plates
- U-235 enrichment
  - U-235 enrichment uncertainty based on standard deviation of measurements

#### Bias

- Room return
  - Simulations excluding room return were found to underestimate k<sub>eff</sub> by 0.00161
- Plate impurities
  - Jemima: measured impurities included but they could be omitted with increase in k<sub>eff</sub> of 0.00019
  - Hafnium: omitting impurities would decrease k<sub>eff</sub> by 0.00090
- Hafnium isotopic composition
  - Increasing Hf-177 content by 10% reduces k<sub>eff</sub> by 0.00346
  - Will precisely measure this value before experiment

Source of	Parameter	Calculated
Uncertainty	Variation	Effect, Δk <sub>eff</sub>
HEU Plate Mass	+0.03%	0.00016
HEU Plate Mass	-0.03%	-0.00006
PE Moderator		
Mass	+0.005 g/cm	0.00086
PE Reflector		
Mass	+0.005 g/cm	0.00040
HEU Plate Gaps	0.00127 cm	-0.00044
U-235		
Enrichment	+0.11%	0.00042
Total		
Uncertainty	0.00114	



# Conclusions

• Thermal, intermediate, and fast critical configurations were designed using available Jemima plate inventory.

#### Hafnium capture

- Standard stacking maximizes thermal sensitivity.
- Sandwich stacking maximizes intermediate sensitivity.
- No configuration was predominately sensitive to fast energy range.

#### Hafnium scatter

 Bunched hafnium configuration maximizes sensitivity to elastic and inelastic scattering at high energy.

#### U-235 fission

- Sensitivity in the intermediate and fast energy regime was verified.
- No configuration was predominately sensitive to thermal energy range.

#### U-235 capture

- Baseline configuration maximized thermal sensitivity.
- Bunched Hf configurations maximized intermediate and fast sensitivity.